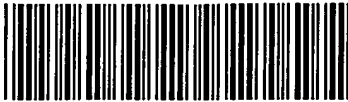


Search Notes



Application/Control No.

10/771,780

Examiner

Rip A. Lee

Applicant(s)/Patent under Reexamination

DIMAIO ET AL.

Art Unit

1713

SEARCHED

Class	Subclass	Date	Examiner
524	574	06-14-2005	h
524	474		
526	281		
526	308		
526	348.3		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST text search + manual search	06-14-2005	M